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# STS4DNF30L

# Dual N-channel 30 V, 0.039 Ω, 4 A SO-8 STripFET™ Power MOSFET

### Features

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>
STS4DNF30L	30 V	< 0.050 Ω	4 A

- Standard outline for easy automated surface mount assembly
- Low threshold drive

### Applications

Switching application

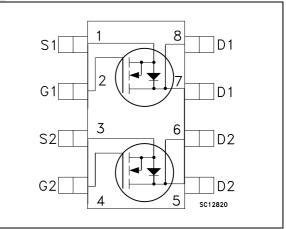
### Description

The STS4DNF60L is a dual N-channel STripFET<sup>TM</sup> Power MOSFET realized with the second generation of STMicroelectronics unique "single feature size" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

THE CLS
S0-8
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Figure 1.

re 1. Internal schematic diagram



Order code	Marking	Package	Packaging
STS4DNF30L	4DF30L	SO-8	Tape and reel

# Contents

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### **Electrical ratings** 1

Table 2.	Absolute r	maximum	ratinas
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Symbol	Parameter	Value	Unit			
$V_{\text{DS}}$	Drain-source voltage (v <sub>gs</sub> = 0)	30	V			
$V_{GS}$	Gate- source voltage	±16	V			
Ι <sub>D</sub>	Drain current (continuos) at $T_C = 25^{\circ}C$	4	А			
Ι <sub>D</sub>	Drain current (continuos) at T <sub>C</sub> = 100°C	2.5	А			
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	16	А			
P <sub>TOT</sub>	Total dissipation at $T_C = 25^{\circ}C$ dual operating	2	w			
1. Pulse width limited by safe operating area						
Table 3.	Thermal data		-			
Symbol	Parameter	Value	Unit			

Table 3	3.	Thermal	data
	•••		~~~~

Symbol	Parameter	Value	Unit
R <sub>thj-a</sub> <sup>(1)</sup>	Thermal resistance junction-ambient max	62.5	°C/W
TJ	Junction temperature	- 55 to 150	°C
T <sub>stg</sub>	Storage temperature range	150	°C

, ≤ 10 sec ctls cosolete cosolete



### **Electrical characteristics** 2

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Parameter	Test conditions	Min.	Тур.	Max.	Unit
Drain-source Breakdown voltage	$I_{D} = 250 \ \mu A, \ V_{GS} = 0$	30			V
Zero gate voltage Drain current (V <sub>GS</sub> = 0)	$V_{DS}$ = Max rating $V_{DS}$ = Max rating, $T_{C}$ = 125 °C			1 10	μΑ μΑ
Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 16 V		404	±100	nA
Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1	0.5		V
Static drain-source on resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 2 \text{ A}$ $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 2 \text{ A}$		0.039 0.046	0.050 0.060	Ω Ω
Dynamic	colette		I		<u> </u>
	Drain-source Breakdown voltage Zero gate voltage Drain current ( $V_{GS} = 0$ ) Gate-body leakage current ( $V_{DS} = 0$ ) Gate threshold voltage Static drain-source on resistance	Drain-source Breakdown voltage $I_D = 250 \ \mu A, \ V_{GS} = 0$ Zero gate voltage Drain current ( $V_{GS} = 0$ ) $V_{DS} = Max \ rating$ $V_{DS} = Max \ rating,$ $T_C = 125 \ ^{\circ}C$ Gate-body leakage current ( $V_{DS} = 0$ ) $V_{GS} = \pm 16 \ V$ Gate threshold voltage $V_{DS} = V_{GS}, \ I_D = 250 \ \mu A$ Static drain-source on resistance $V_{GS} = 10 \ V, \ I_D = 2 \ A$	Drain-source Breakdown voltage $I_D = 250 \ \mu A, \ V_{GS} = 0$ 30Zero gate voltage Drain current ( $V_{GS} = 0$ ) $V_{DS} = Max \ rating, \ T_C = 125 \ ^C$ $V_{DS} = Max \ rating, \ T_C = 125 \ ^C$ Gate-body leakage current ( $V_{DS} = 0$ ) $V_{GS} = \pm 16 \ V$ $V_{GS} = \pm 16 \ V$ Gate threshold voltage $V_{DS} = V_{GS}, \ I_D = 250 \ \mu A$ 1Static drain-source on resistance $V_{GS} = 10 \ V, \ I_D = 2 \ A \ V_{GS} = 4.5 \ V, \ I_D = 2 \ A$	Drain-source Breakdown voltage $I_D = 250 \ \mu A, \ V_{GS} = 0$ 30Zero gate voltage Drain current ( $V_{GS} = 0$ ) $V_{DS} = Max \ rating,$ $T_C = 125 \ ^C$ $V_{DS} = Max \ rating,$ $T_C = 125 \ ^C$ Gate-body leakage current ( $V_{DS} = 0$ ) $V_{GS} = \pm 16 \ V$ $V_{GS} = \pm 16 \ V$ Gate threshold voltage $V_{DS} = V_{GS}, \ I_D = 250 \ \mu A$ 1Static drain-source on resistance $V_{GS} = 10 \ V, \ I_D = 2 \ A$ 0.039 0.046	Drain-source Breakdown voltage $I_D = 250 \ \mu A, \ V_{GS} = 0$ 30Zero gate voltage Drain current ( $V_{GS} = 0$ ) $V_{DS} = Max \ rating$ $V_{DS} = Max \ rating,$ $T_C = 125 \ ^{\circ}C$ 1Gate-body leakage current ( $V_{DS} = 0$ ) $V_{GS} = \pm 16 \ V$ $\pm 100$ Gate threshold voltage $V_{DS} = V_{GS}, \ I_D = 250 \ \mu A$ 1Static drain-source on resistance $V_{GS} = 4.5 \ V, \ I_D = 2 \ A$ 0.039 0.046

Table 4. On/off states

#### Table 5. Dynamic

Symb	ol Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance			330		pF
C <sub>os</sub>	Output capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz,	-	90		pF
C <sub>rs</sub>	Reverse transfer capacitance	$V_{GS} = 0$		40		pF
Qg	Total gate charge			6.5	9	nC
Q <sub>gt</sub>	Gate-source charge	$V_{DD} = 24 \text{ V}, \text{ I}_D = 4 \text{ A},$ $V_{GS} = 10 \text{ V}$	-	3.6		nC
Qgc	Gate-drain charge			2		nC
Solete						



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on delay time Rise time	$V_{DD} = 15 \text{ V}, \text{ I}_D = 2 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 4.5 \text{ V}$ (see <i>Figure 13</i> )	-	11 100	-	ns ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-off Delay Time Fall Time	V <sub>DD</sub> =15 V, I <sub>D</sub> =2 A, R <sub>G</sub> =4.7 Ω, V <sub>GS</sub> = 4.5 V (see <i>Figure 13</i> )	-	25 22	-	ns ns

Table 6.Switching times

### Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current			. (	4	А
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		16	А
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 4 \text{ A}, V_{GS} = 0$	Q	5	1.2	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 4 \text{ A}, V_{DD} = 20 \text{ V}$ di/dt = 100 A/µs, $T_j = 150 \text{ °C}$ (see <i>Figure 15</i> )	-	30 18 1.2		ns nC A

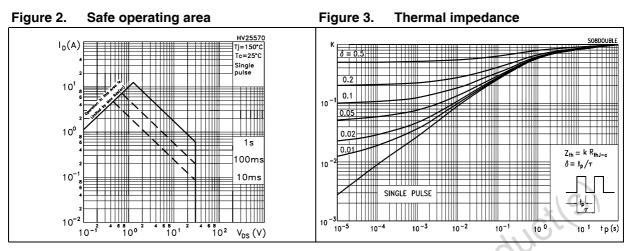
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1. Pulse width limited by safe operating area.

2. Pulsed: Pulse duration = 300 µs, duty cycle 1.5 %



### 2.1 Electrical characteristics (curves)





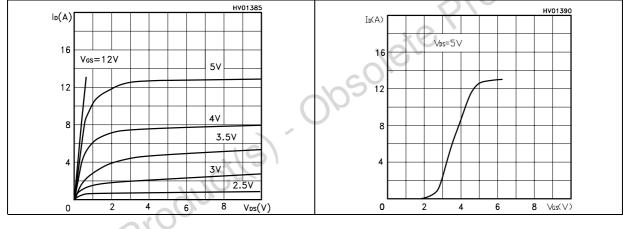
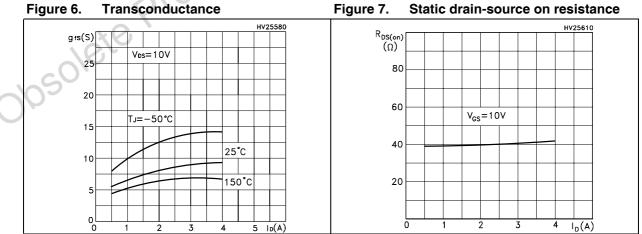
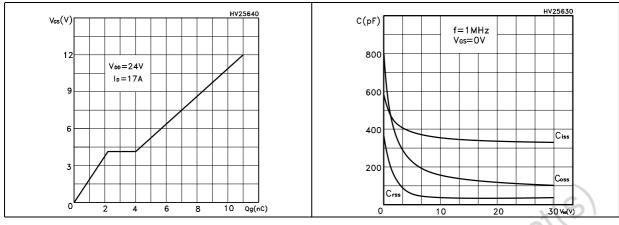


Figure 5.

**Transfer characteristics** 







Gate charge vs gate-source voltage Figure 9. Figure 8. **Capacitance variations** 

Figure 10. Normalized gate threshold voltage Figure 11. Normalized on resistance vs vs temperature

temperature

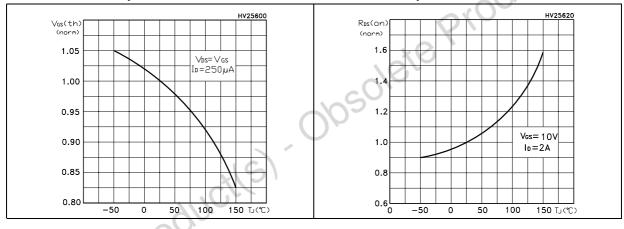
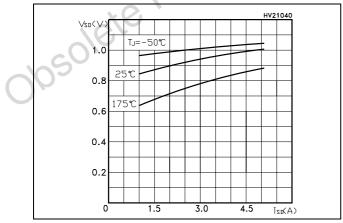


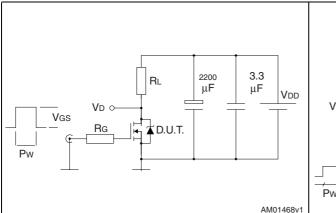
Figure 12. Source-drain diode forward characteristics





## 3 Test circuits

Figure 13. Switching times test circuit for resistive load



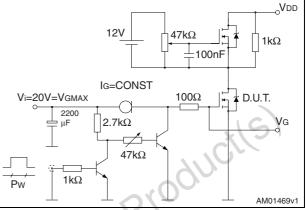


Figure 14. Gate charge test circuit

Figure 15. Test circuit for inductive load switching and diode recovery times



L

JJJJ

D.U.T.

2200

μF

3.3

μF

Vdd

AM01471v1

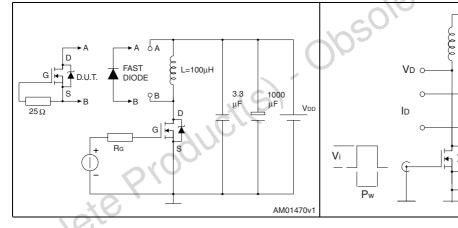
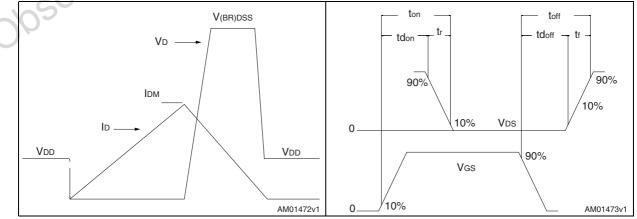


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



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### 4 Package mechanical data

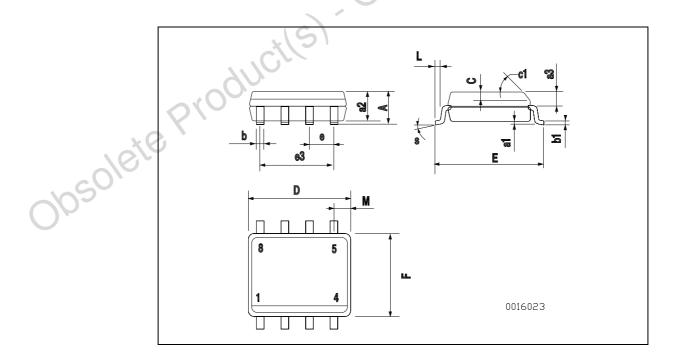
In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

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obsolete Product(s)- Obsolete Product(s)

DIM.	mm.			inch			
	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX	
А			1.75			0.068	
a1	0.1		0.25	0.003		0.009	
a2			1.65			0.064	
a3	0.65		0.85	0.025		0.033	
b	0.35		0.48	0.013		0.018	
b1	0.19		0.25	0.007		0.010	
С	0.25		0.5	0.010		0.019	
c1	45 (typ.)						
D	4.8		5.0	0.188	.00	0.196	
E	5.8		6.2	0.228		0.244	
е		1.27		X	0.050		
e3		3.81		× 0,	0.150		
F	3.8		4.0	0.14		0.157	
L	0.4		1.27	0.015		0.050	
М			0.6			0.023	
S	8 (max.)						

**SO-8 MECHANICAL DATA** 



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### 5 Revision history

### Table 8. Revision history

	Date	Revision	Changes
	11-Sep-2006	1	First version
	15-Nov-2006	2	The document has been reformated
	17-Jun-2010	3	Marking in Table 1: Device summary has been corrected
obsole	tepro	ductl	obsolete Producils)



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